

From MIMOSA-26 to ULTIMATE

Marc Winter (IPHC-Strasbourg)

(on behalf of the CMOS-ILC Team)

▷ more information on IPHC Web site: <http://www.iphc.cnrs.fr/-CMOS-ILC-.html>

▷ Most of the information distributed is confidential

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- **Introductory remarks on CMOS pixel sensors developed at IPHC**
- **MIMOSA-26 :**
 - ▷ performances & applications
 - ▷ standard vs high-resistivity epitaxy
- **Extension of MIMOSA-26 towards ULTIMATE : MIMOSA-22AHR**
 - ▷ larger pitch
 - ▷ signal amplification
 - ▷ radiation tolerance
- **Summary – Conclusions**

■ Team composition :

- micro-circuit designers : 9 staff (+2 supports), 1-2 post-doc, 6-7 PhD
- test & instrumentation engineers : 6 staff
- physicists : 3 staff, 4 post-doc, 2 PhD

■ Involvements besides STAR:

- **Sensor devt:** 3D chips, depleted epi., dosimetry (pixels with ADC), beta camera, ...
- **System integration studies** : double-/single-sided ladders \equiv 0.3%/0.1% X_0 (EU-FP7 projects)
- **HEP experiments besides STAR:** CBM/FAIR, ILC, (ALICE recently)
- **Exploiting MIMOSA sensors** for various beam telescopes & spectrometres

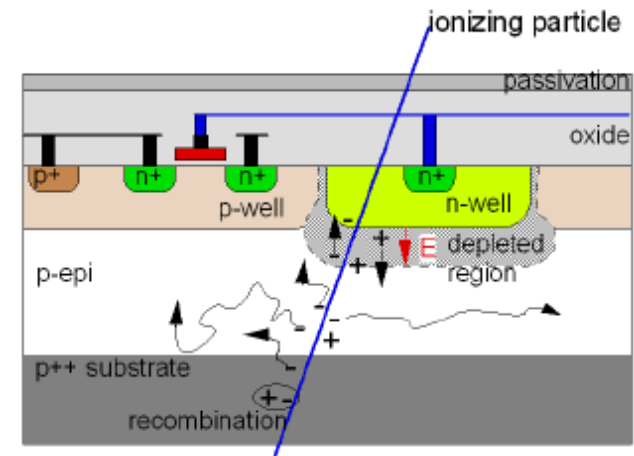
■ Collaborators (besides STAR coll.):

- IRFU-Saclay for chip design related to ILC (and may be for ALICE upgrade)
- IKF-Frankfurt (CBM) for chip evaluation and system integration studies
- Oxford - Bristol - DESY (& CERN) for system integration studies
- DESY, Univ. Geneva, INFN for EUDET(FP-6) & AIDA (FP-7) Beam Telescope (BT)
- IPN-Lyon (IN2P3) for beta (& proton)imaging
- Nuclear physics teams for hadrontherapy trackers & imagers
- Users of MIMOSA sensors for various applications (subatomic physics as well as spin-offs)

CMOS Pixel Sensors: General Remarks

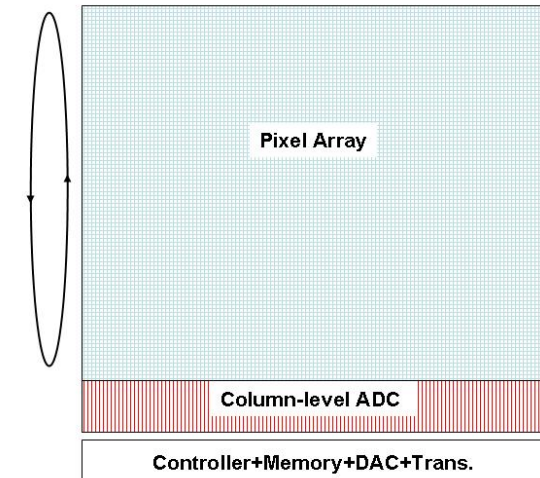
- **Prominent features of CMOS pixel sensors:**

- ✧ high granularity \Rightarrow excellent (micronic) spatial resolution
- ✧ very thin (signal generated in 10-20 μm thin epitaxial layer)
- ✧ signal processing μ -circuits integrated on sensor substrate



- **Sensor organisation:**

- ✧ signal sensing and analog processing in pixel array
- ✧ mixed and digital circuitry integrated in chip periphery
- ✧ read-out in rolling shutter mode
(pixels grouped in columns read out in //)



- **Intrinsic limitations of technology :**

- ✧ very thin sensitive volume \Rightarrow impact on signal magnitude
- ✧ standard process sensitive volume almost undepleted \Rightarrow impact on radiation tolerance & speed
- ✧ commercial fabrication (parametres) \Rightarrow not optimised for charged particle detection
 \Rightarrow impact on sensing performances and radiation tolerance

- **Limitations of the fabrication process retained for ULTIMATE:**

- ✧ only 4 ML \Rightarrow rolling shutter sequencer in $350 \mu m$ wide side band
- ✧ feature size \Rightarrow restricted nb of transistors in the pixel
- ✧ oxide thickness (from feature size) \Rightarrow weakens the tolerance to ionising radiation
- ✧ double-well technology \Rightarrow restricted circuitry inside pixel

- **Limitations due to the STAR environment :**

- ✧ limited cooling \Rightarrow power consumption is a concern (consequences on SNR, alignment)
- ✧ limited cooling \Rightarrow reduced noise performance, in particular after irradiation (though not critical)

Development Strategy of Fast CMOS Sensors

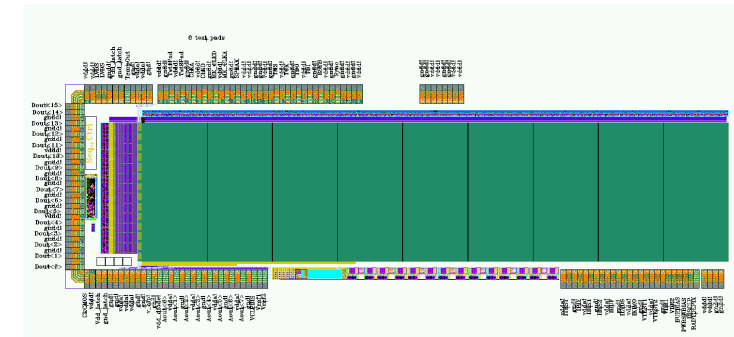
Target value : read-out time $\lesssim 20 - - - - 200 \mu s$ \rightarrow sensors organised in pixel columns read out in //

R&D organisation : 2 simultaneous R&D lines \Rightarrow 2 types of μ circuits

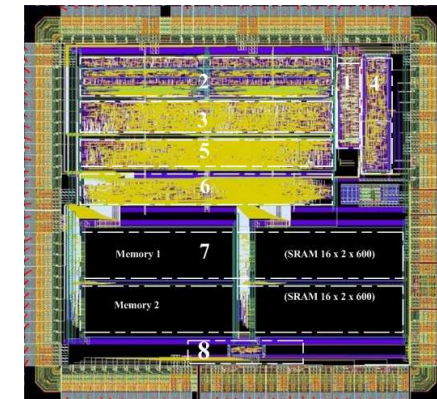
MIMOSA-22



- architecture of pixel arrays organised in columns read out in //
 - ▷ CDS and pre-amp μ circuit in each pixel
 - ▷ 1 discriminator ending each column
 - \hookrightarrow MIMOSA-8 (2004), MIMOSA-16 (2006), MIMOSA-22 (2007/08)
 - \hookrightarrow PHASE-1 (2008/09)



- \emptyset μ circuits & output memories : SUZE-01 (2007) \longrightarrow
 - \hookrightarrow combined with MIMOSA-22 \triangleright MIMOSA-26 (2008/09)
 - \hookrightarrow ULTIMATE (2010/11)



Main Characteristics of the MIMOSA-22 Sensor

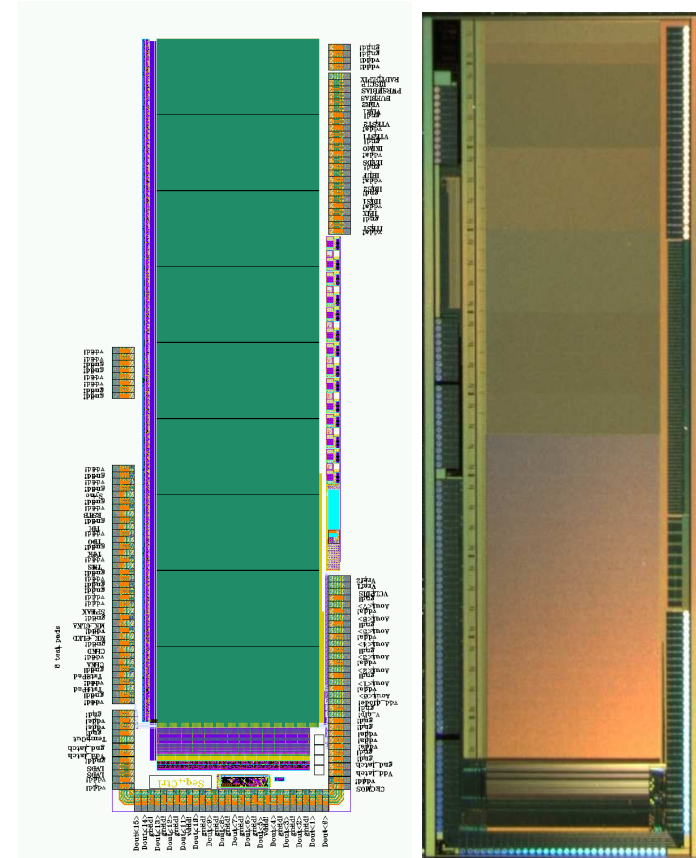
♣ Extension of MIMOSA-16 \rightarrow larger surface, smaller pitch, optimised pixel, JTAG, more testability

Pixel characteristics :

- ✳ pitch : $18.4 \mu m$ (compromise resolution/pixel layout)
- ✳ diode surface : $\sim 10 - 20 \mu m^2$ to optimise charge coll. & gain
- ✳ 128 columns ended with discriminator
- ✳ 576 pixels per column (\equiv final column length)
- ✳ 8 columns with analog output for test purposes
- ✳ 9 sub-matrices of 64 rows :
 - 17 pixel designs w/o ionising rad. tol. diode
- \Rightarrow active digital area $\sim 25 \text{ mm}^2$ (128 x 576 pixels)
- ✳ read-out time $\sim 100 \mu s$ ($\sim 10^4$ frames/s) at 100 MHz

4 different versions fabricated up to now (prototype shuttle)

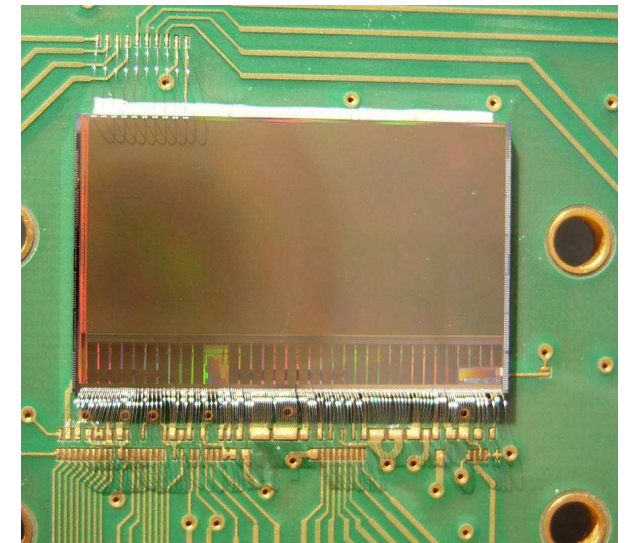
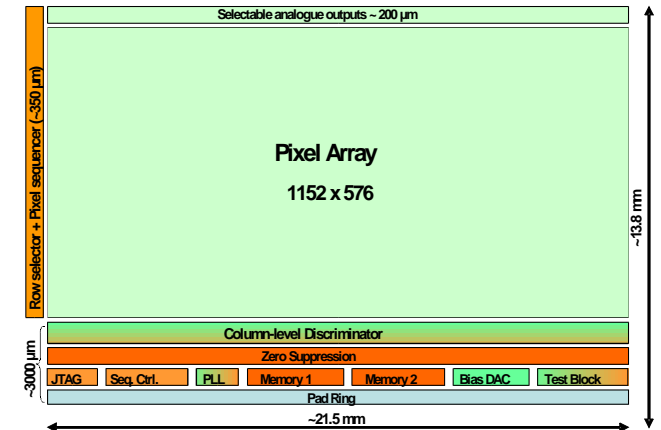
- ✳ 3 versions with standard epitaxial layer (2007, 2008, 2009)
- ✳ 1 version with high resistivity epitaxial layers (2010)



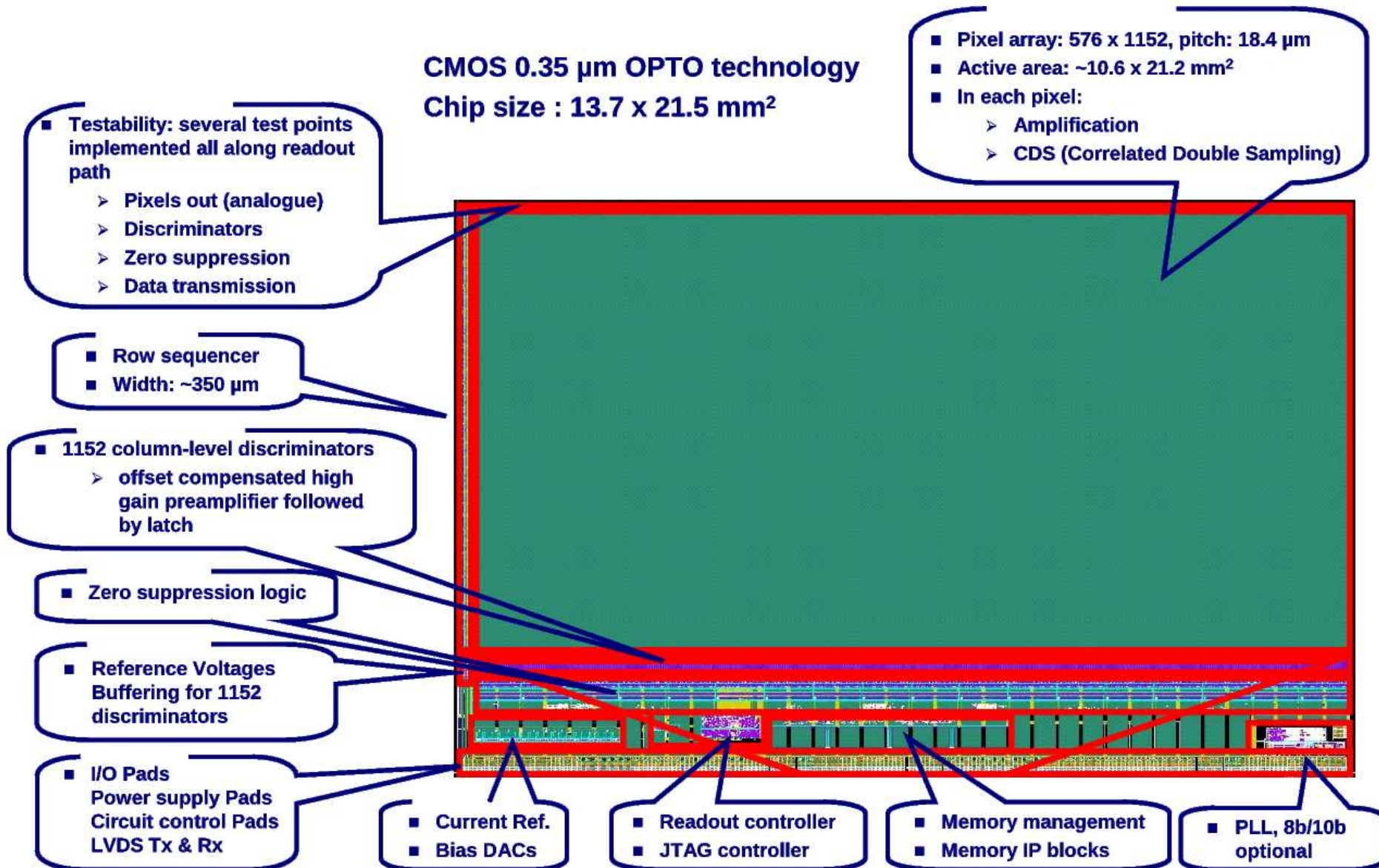
MIMOSA-26: Architecture Baseline for ULTIMATE

● Main characteristics of MIMOSA sensor equipping EUDET BT:

- * $0.35 \mu m$ process with high-resistivity epitaxial layer
(coll. with IRFU/Saclay)
- * column // architecture with in-pixel amplification (CDS)
and end-of-column discrimination, followed by \emptyset
↳ binary charge encoding
- * active area: 1152 columns of 576 pixels ($21.2 \times 10.6 \text{ mm}^2$)
- * pitch: $18.4 \mu m \rightarrow \sim 0.7$ million pixels
charge sharing $\Rightarrow \sigma_{sp} \sim 3\text{-}3.5 \mu m$ (despite binary encoding)
- * $t_{r.o.} \lesssim 100 \mu s$ ($\sim 10^4$ frames/s)
 \Rightarrow suited to $> 10^6$ part./cm²/s
- * 2 outputs at 80 MHz
- * $\sim 250 \text{ mW/cm}^2$ power consumption (fct of N_{col})



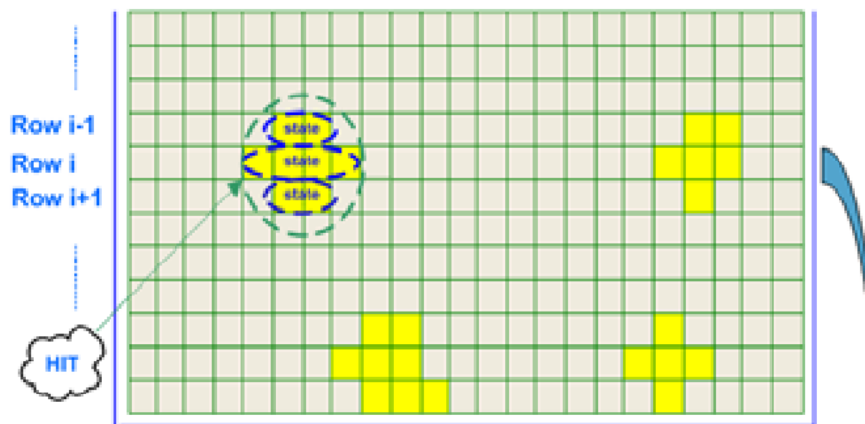
MIMOSA-26: Functionality Implementation



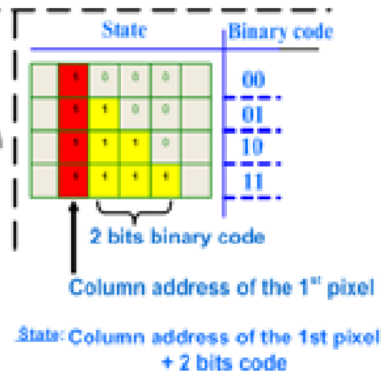
courtesy of Ch. Hu-Guo / TWEPP-2010

MIMOSA-26 Zero-Suppression Logic

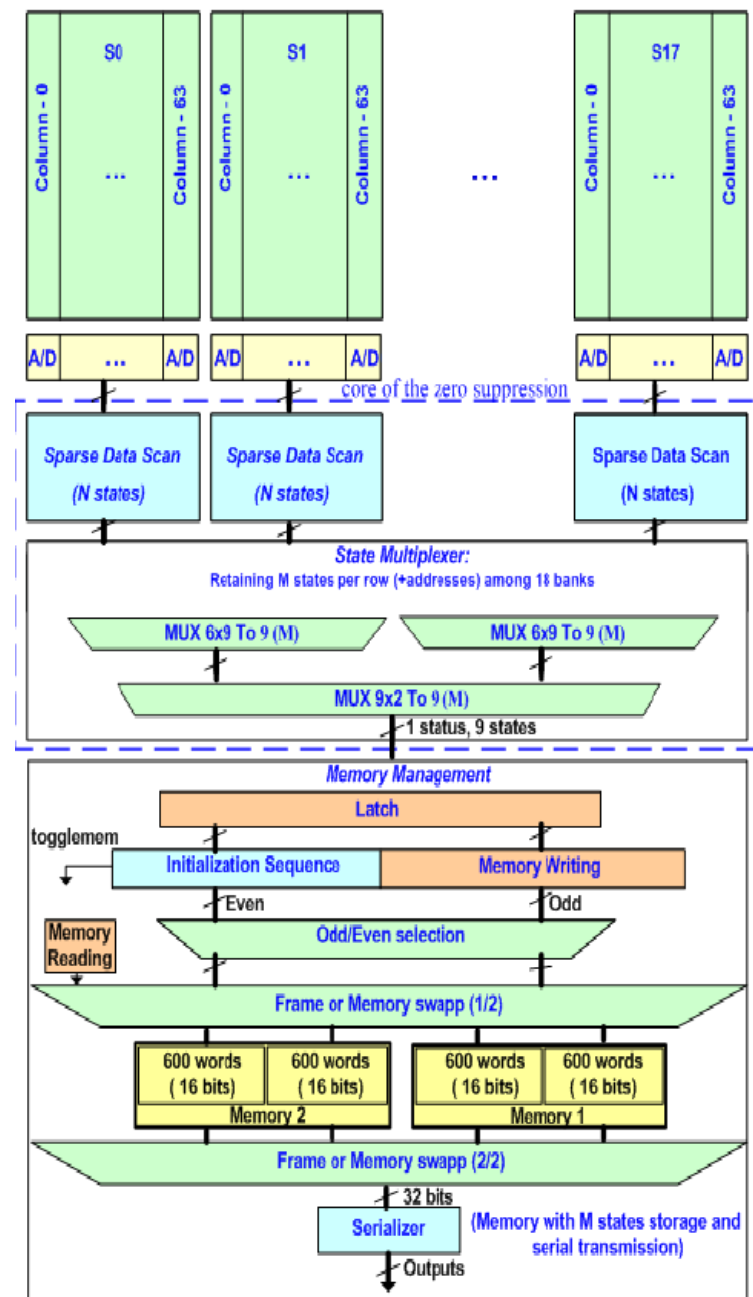
Representation of hits in a matrix of pixels



After AD conversion by discriminators



- Encoding limited to rows
⇒ no row to row correlation for clustering
- Same logic implemented in Ultimate



- **2 engineering runs:**

- ※ 2009 ▷ 6 wafers with standard epitaxial layer (14 μm thick)
- ※ 2010 ▷ 6 wafers with various epitaxial layers :
1 standard (14 μm thick), 5 high-resistivity (10, 15 and 20 μm thick)

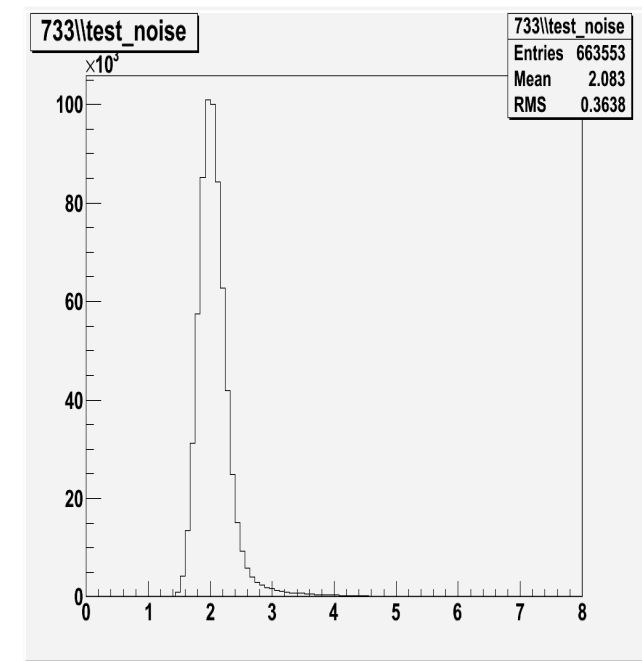
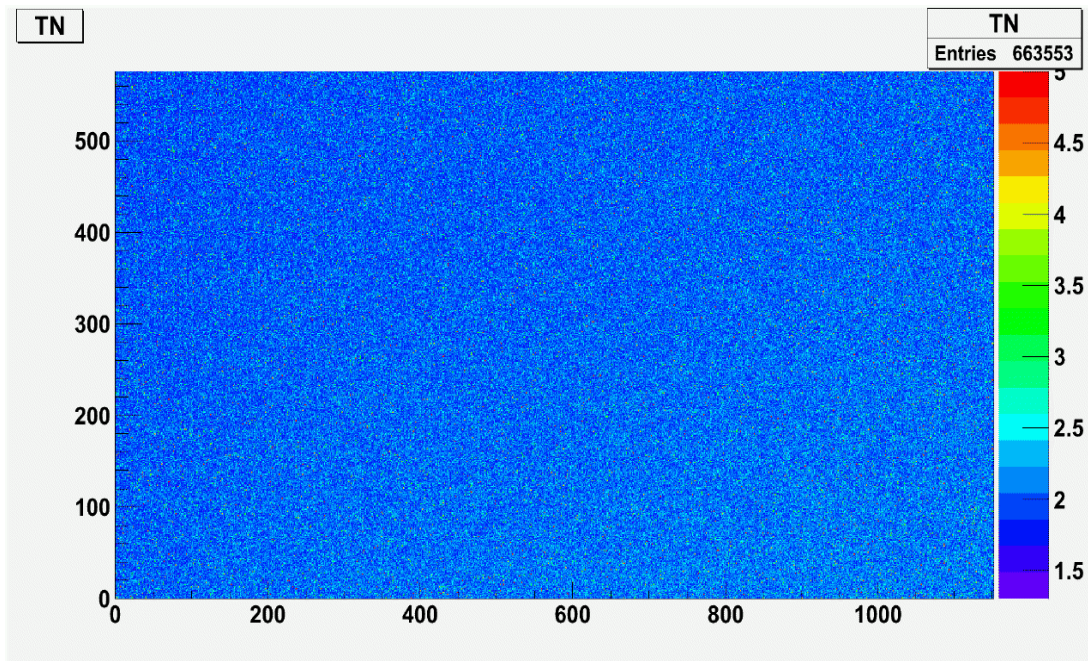
- **> 90 sensors tested :**

Epitaxial layer	fully operational	$< 10^{-3}$ dead pixels	few 10^{-3} dead pixels	unusable
standard	55	6	6	3
high-res	19	1	2	1

- **Global figure of fabrication yield:**

- ※ yield : $\sim 75\%$ "perfect" sensors and $\sim 90\%$ usable
- ※ 50 μm thin (4, 1, 0, 1) and high-resistivity sensors do not behave differently (statistics limited)

MIMOSA-26 Lab Tests: Noise Performance

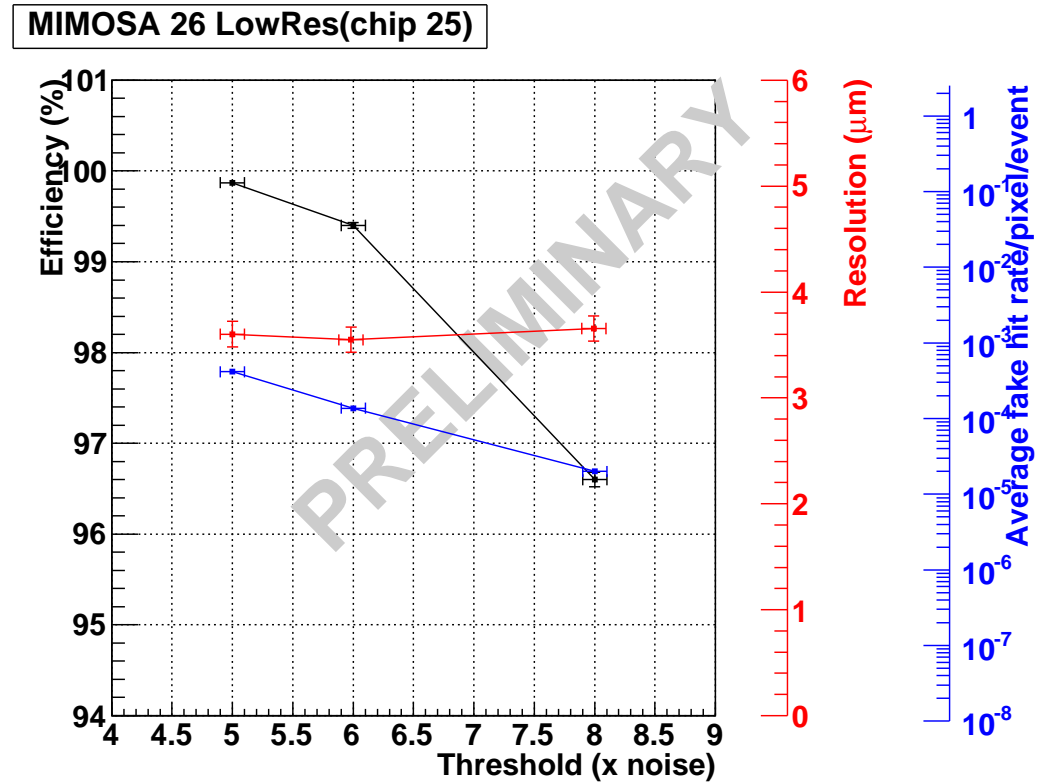


- Noise uniformity tested on > 60 sensors (analogue output)
- Main conclusions:
 - * no dead pixel over > 50 arrays of 665,000 pixels !
 - * $N \lesssim 14 e^- ENC$
 - * marginal noise dispersion between chips

MIMOSA-26 Beam Tests: Summary

- MIMOSA-26 sensors quite extensively characterised by now (analysis not yet completed):

- ✧ MIMOSA-26 operated with
 - ≥ 99.5 % detection efficiency over the whole sensitive area, with a fake rate $\lesssim O(10^{-4})$
- ✧ Optimal discri. threshold $\sim 5-6 \times$ Noise value
- ✧ $\sigma_{sp}^{M26} < 4 \mu m$

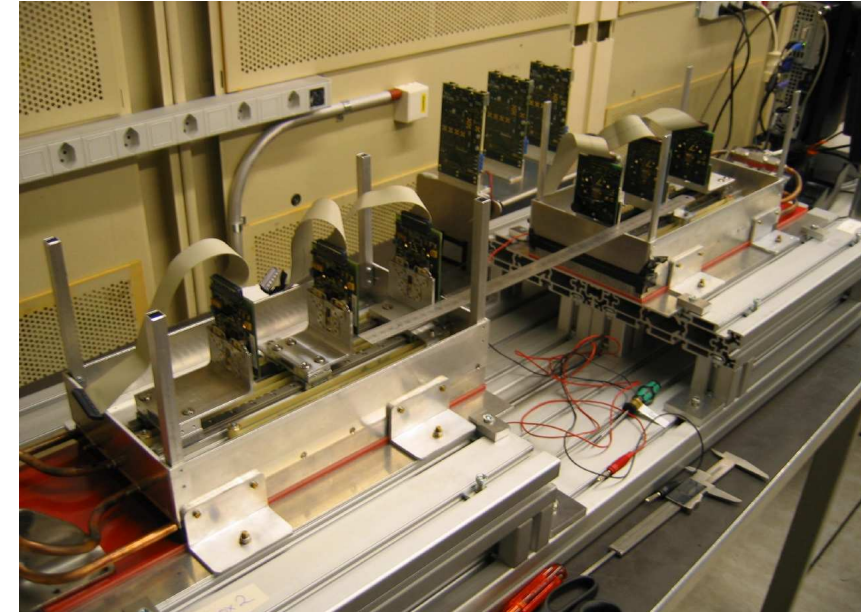


- Conclusion on MIMOSA-26:

- ✧ chip operational for the final EUDET BT and several other applications (BT and Vx Det.)
- ✧ chip architecture validated for developpement of application specific sensors:
 - ▷ STAR-PXL ▷ CBM-MVD ▷ ALICE-ITS ▷ ILD-VTX, ...

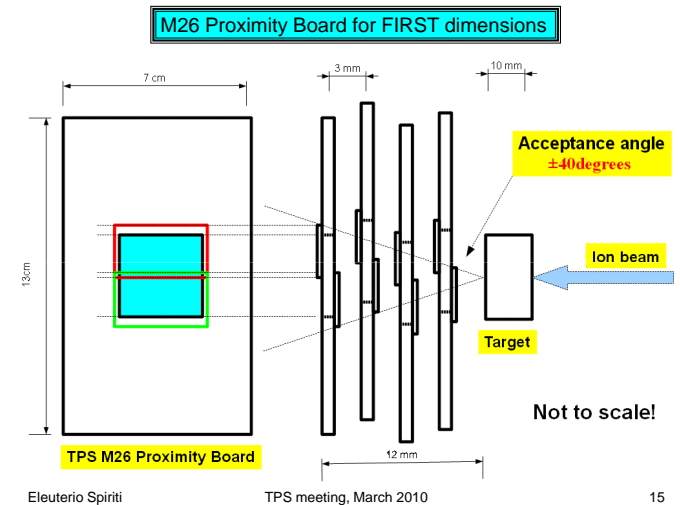
Direct Applications of MIMOSA-26

- **Beam telescope of the FP6 project EUDET**
 - ✧ 2 arms of 3 planes (plus 1-2 high resolution planes)
 - ✧ M-26 thinned to $50 \mu m$
 - ✧ $\sigma_{extrapol.} \sim 1-2 \mu m$ EVEN with e^- (3 GeV, DESY)
 - ✧ frame read-out frequency $O(10^4)$ Hz
 - ✧ running since '07 (demonstrator: analog outputs)
at CERN-SPS & DESY (numerous users)



- **Spin-offs :**

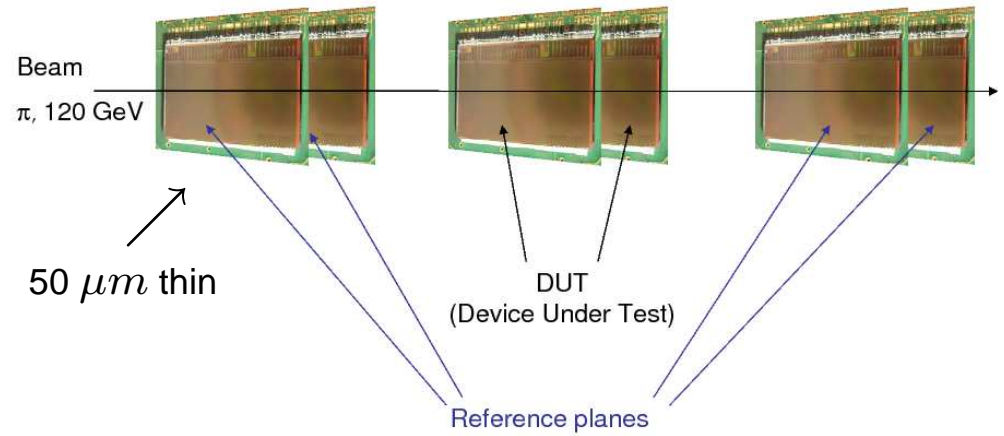
- ✧ **Several BT copies :** foreseen for detector R&D
- ✧ **BT for mass spectroscopy, proton radiography, etc.**
- ✧ **CBM (FAIR) :** MVD demonstrator (2-sided layers) for CBM-MVD (HP-2 project)
- ✧ **FIRST (GSI) :** VD for hadrontherapy $d\sigma/d\Omega$ measurements $\triangleright \triangleright$



MIMOSA-26 with High-Resistivity Epitaxial Layer

● M.i.p. detection with LOW & HIGH resistivity CMOS sensors combined in a Beam Telescope (BT)

- ✧ 4 EUDET ref. sensors & 2 sensors under test
- ✧ June 2010 at CERN-SPS (~ 120 GeV pions)
- ✧ sensor variants : standard epitaxy ($14 \mu m$ thick)
& high-resistivity epitaxy (10 & $15 \mu m$ thick)

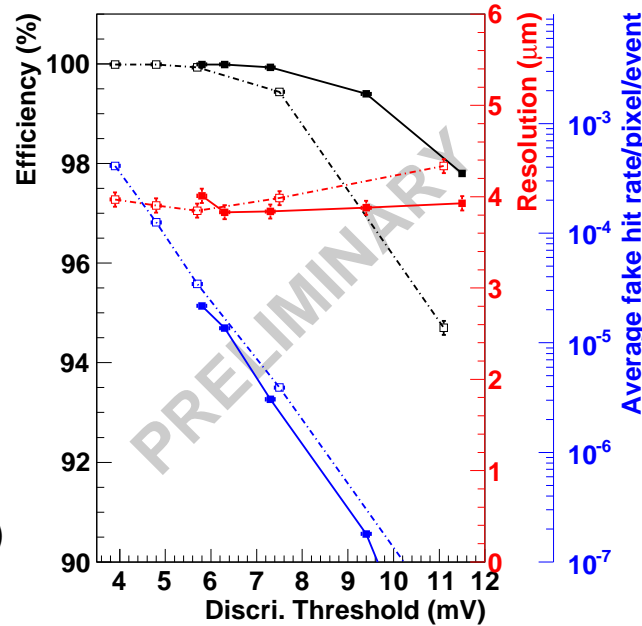


● Conclusions:

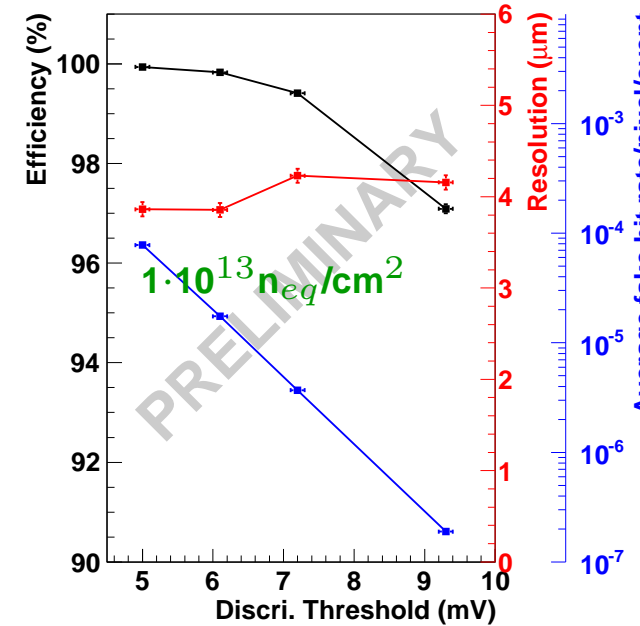
- ✧ det. eff. $\sim 100\%$ ($SNR \sim 40$) for very low fake rate:
 - ▷ plateau until fake rate of few 10^{-6}
- ✧ single point resolution $\lesssim 4 \mu m$
- ✧ det. eff. still $\sim 100\%$ after exposure to fluence of $1 \cdot 10^{13} n_{eq}/cm^2$ ($T \sim 0^\circ C$)

⇒ **Excellent detection performances with high-resistivity epitaxial layer** despite moderate resistivity ($400 \Omega \cdot cm$) and poor depletion voltage ($< 1 V$)

Mi26 HR-15 and HR-10 Efficiency, Fake rate and Resolution



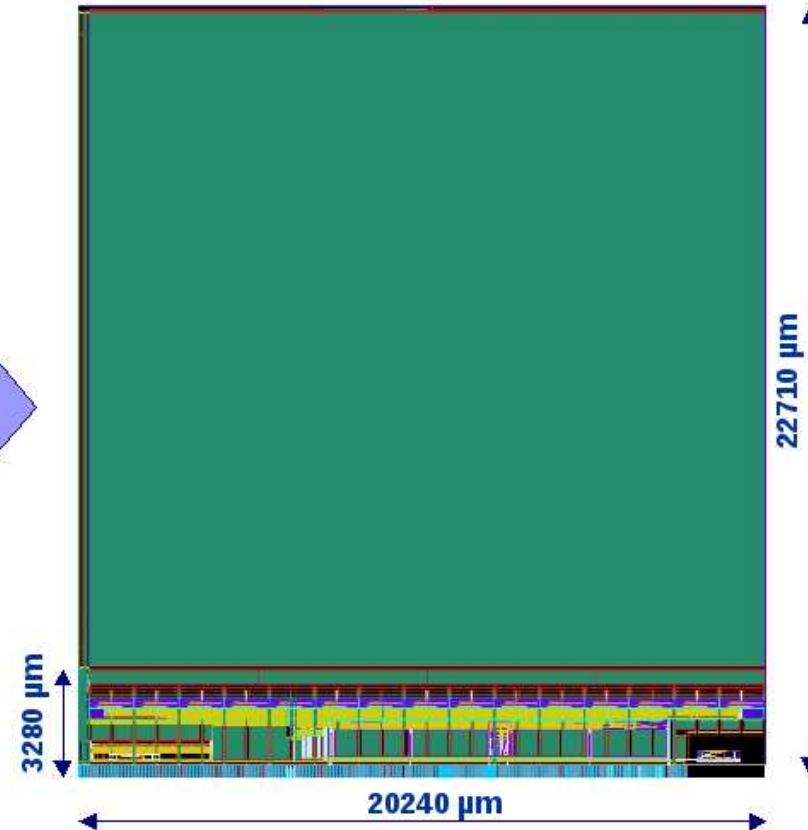
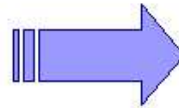
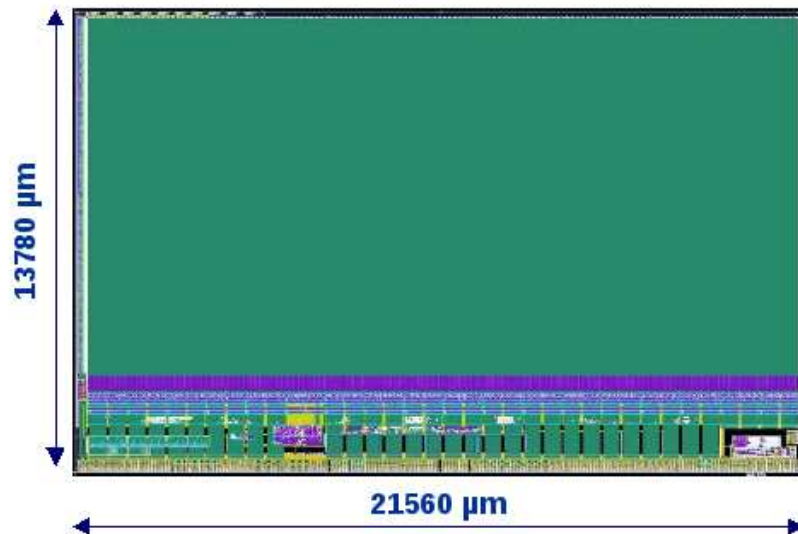
Mi26 HR-15 Efficiency, Fake rate and Resolution for a chip irradiated with a $1.10^{13} n_{eq}$ dose at $T_{op} \sim 0^\circ C$





EXTENSION of MIMOSA-26 to ULTIMATE

From MIMOSA-26 to Ultimate



- Half reticle 1152 x 567 pixel matrix
- Temperature ~20 °C
- Light power consumption constrains
- Space resolution ~4 μm
- No constrains on radiation tolerance

- Full reticle 960 x 928 pixel matrix
 - ↳ Longer integration time ~200 μs
- Temperature 30-35 °C
- Power consumption ~100 mW/cm²
- Space resolution < 10 μm
- 150 kRad / yr & few 10¹² Neq /cm² /yr

➔ **Optimisation**

courtesy of Ch. Hu-Guo / TWEPP-2010

MIMOSA-22AHR: Motivations, Properties, Tests Performed

● Motivations :

- ✧ validate larger pitch design \Rightarrow power dissipation
- ✧ try enhancing in-pixel amplification \Rightarrow sensitivity to discri. offset
- ✧ enhance radiation tolerance at 30° C
- ✧ explore and validate new epitaxial layers (AMS home made vs provider)

● Main components:

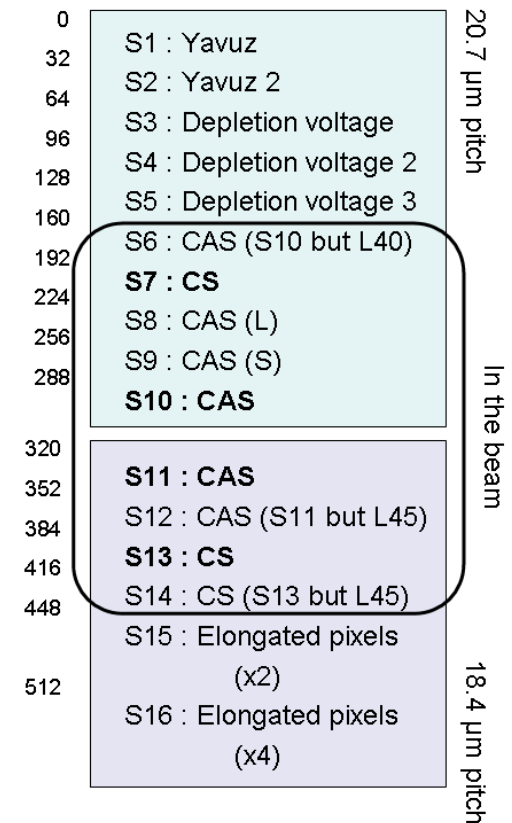
- ✧ pitch: 20.7 μm (UTIMATE) and 18.4 μm (MIMOSA-26)
- ✧ in-pixel amplification: Common Source & Cascode
- ✧ various features against ionising radiation damage: ETL, wide T gate
- ✧ features against non-ionising radiation damage: diode size, depletion potential

● Fabrication:

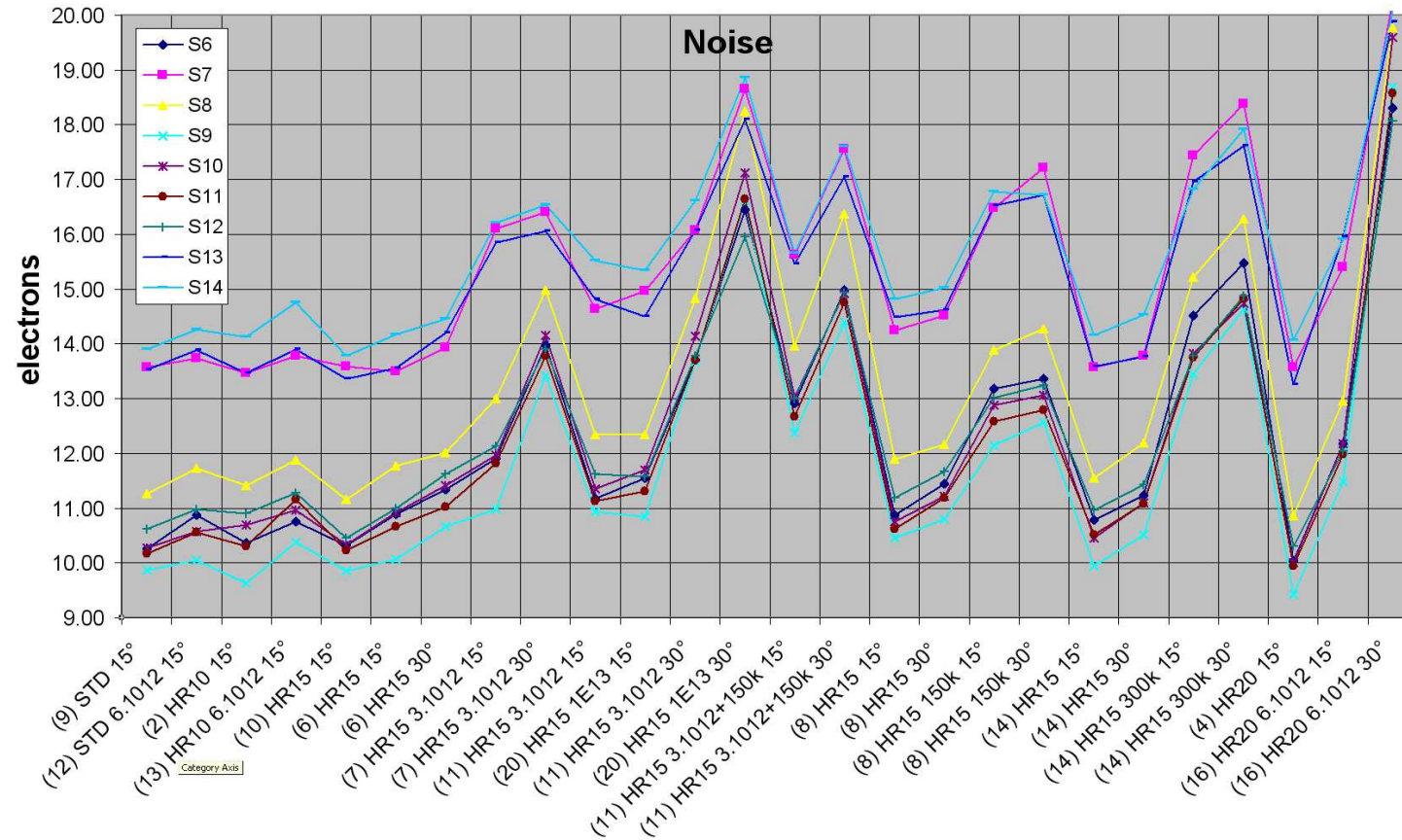
- ✧ part of an AMS-0.35 μm engineering run submitted in May 2010 \rightarrow back in July
- ✧ various epitaxial layers: standard (M-22 & M-26), HR-10 (M-26), HR-15 (AMS), HR-20 (AMS)

● Tests performed (mainly at 3.3 V):

- ✧ extensive lab tests: CCE (^{55}Fe), noise (fake rate) ✧ HR-15 and HR-10 tested at CERN-SPS (August & Sept. 2010)
- ✧ irradiation tolerance tests: 150 kRad, $3 \cdot 10^{12} n_{eq}/cm^2$ and combined ✧ temperature dependence: 20° C and 30° C
- ✧ "STAR running conditions": 150 kRad \oplus $3 \cdot 10^{12} n_{eq}/cm^2$ \oplus 30° C \oplus 75 MHz (should have been 50 MHz)



MIMOSA-22AHR : Noise Performance



MIMOSA-22AHR: Before Irradiation

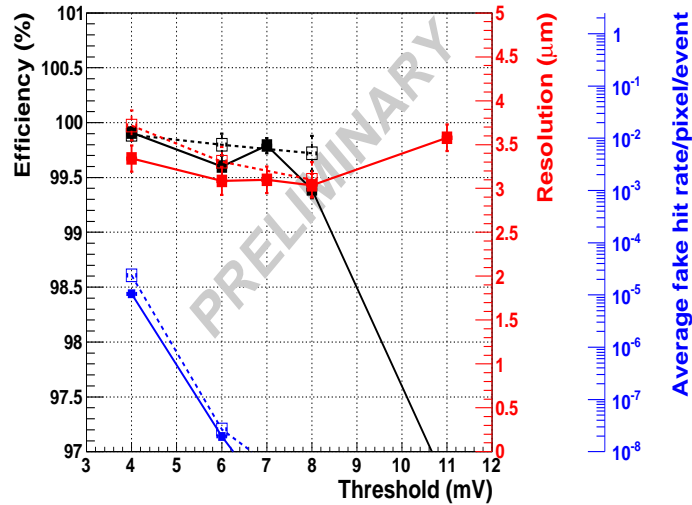
Tests performed at CERN-SPS:

- ✧ sensor mounted on beam telescope (4 pairs of Si-strip detectors)
- ✧ vary discriminator threshold (JTAG), temperature, clock frequency
- ✧ measure detection efficiency, fake hit rate, single point resolution

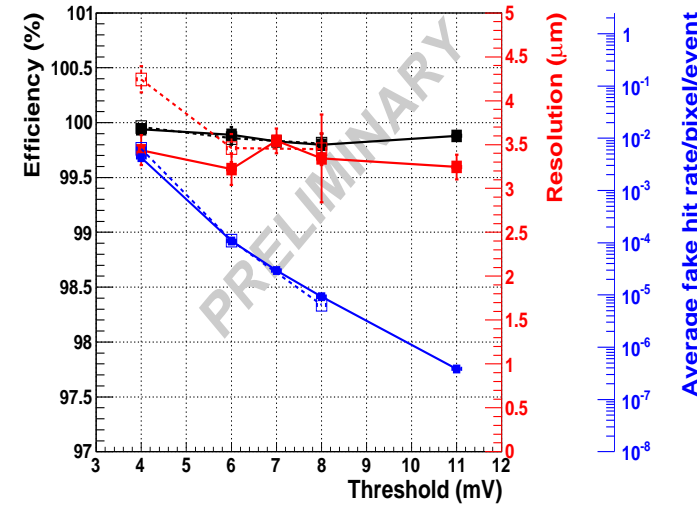
Results for 20.7 μm pitch pixels \triangleright mV-SNR equivalence at 30 $^{\circ}$ C

Threshold \triangleright	4 mV	6 mV	8 mV
S7	4.1	6.4	8.7
S10	2.5	4.2	5.9
S6	2.7	4.4	6.1
S8	2.5	4.2	5.9

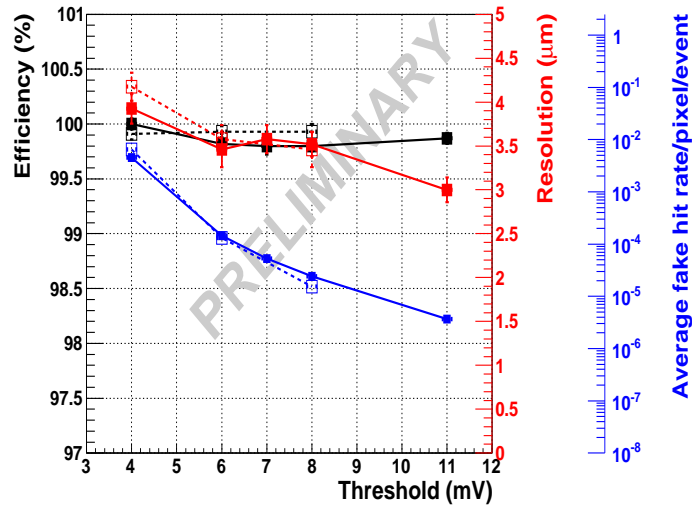
S7 (CS)



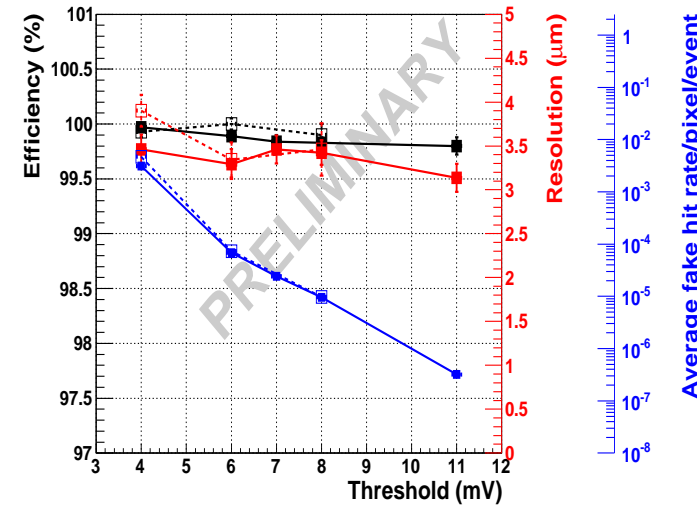
S10 (CAS)



S8 (CAS large diode)



S6 (CAS)



Typical noise performance : 12-14 e^{-} ENC

MIMOSA-22AHR: Before Irradiation

- Efficiency vs fake hit rate:

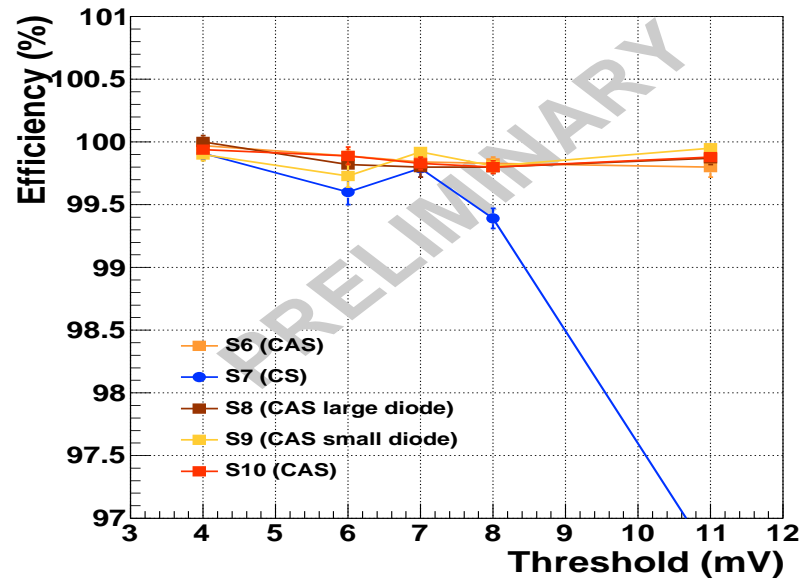
- ✧ define threshold values allowing high detection efficiency and low fake rate

- ⇒ keep fake rate $\lesssim 10^{-4}$

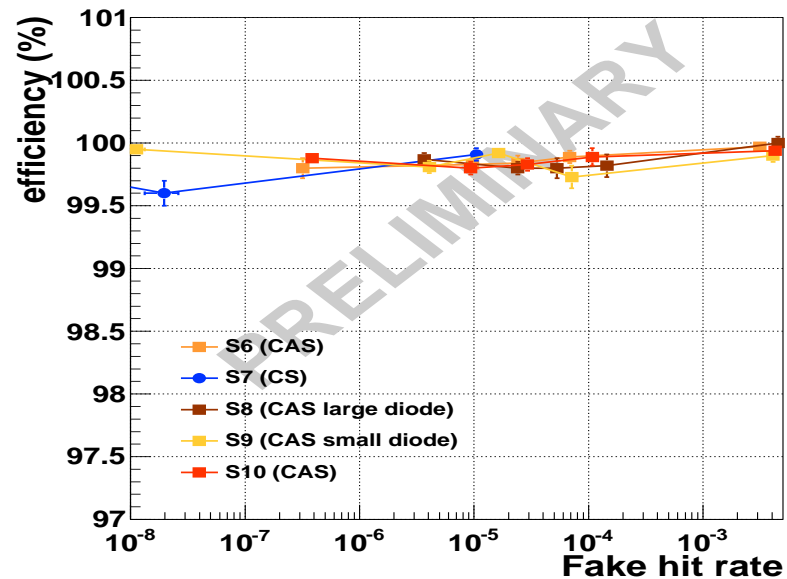
- Results for $20.7 \mu m$ pitch pixels ▷
mV-SNR equivalence at $30^\circ C$

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Efficiency vs Threshold



Efficiency vs Fake hit rate



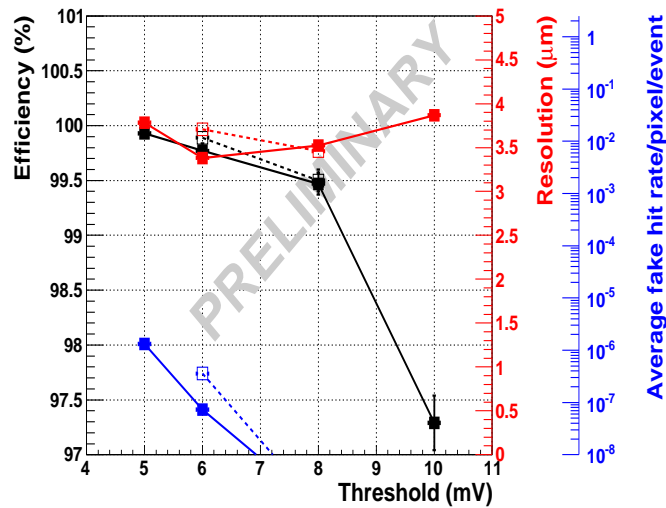
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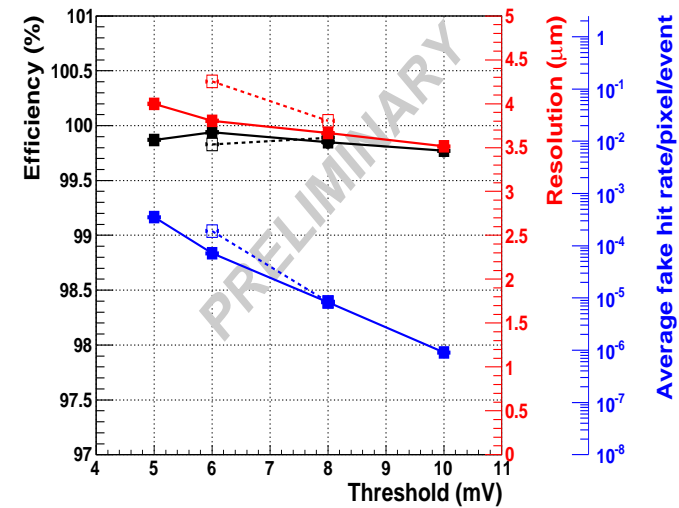
Results for $20.7 \mu m$ pitch pixels \triangleright mV-SNR equivalence at $30^\circ C$

Threshold \triangleright	6 mV	8 mV
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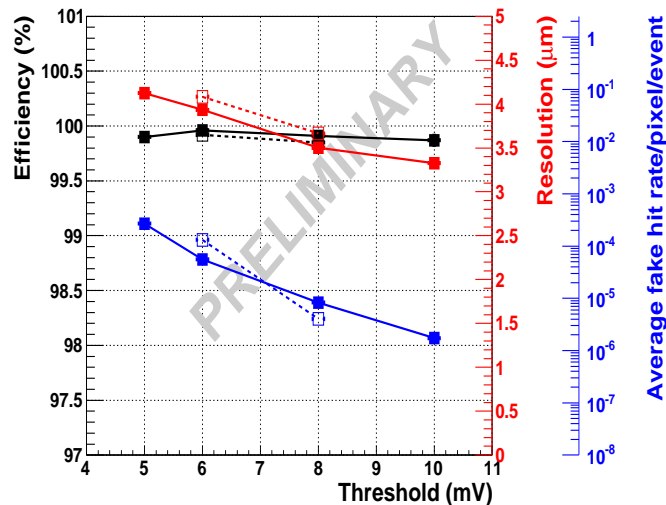
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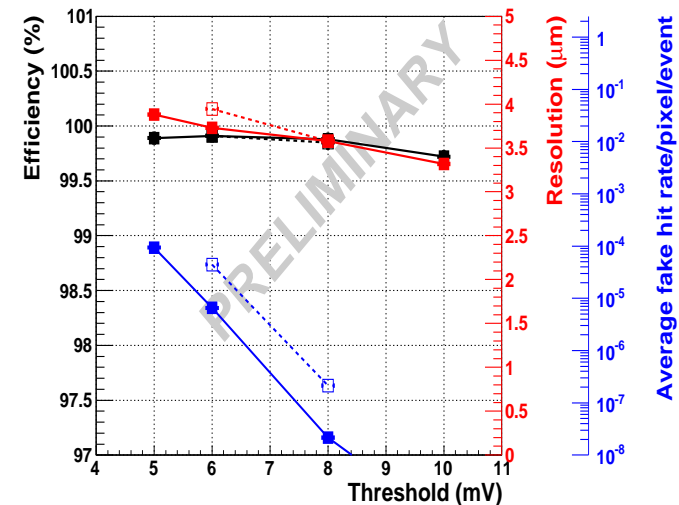
S10 (CAS)



S8 (CAS-L)



S6 (CAS)

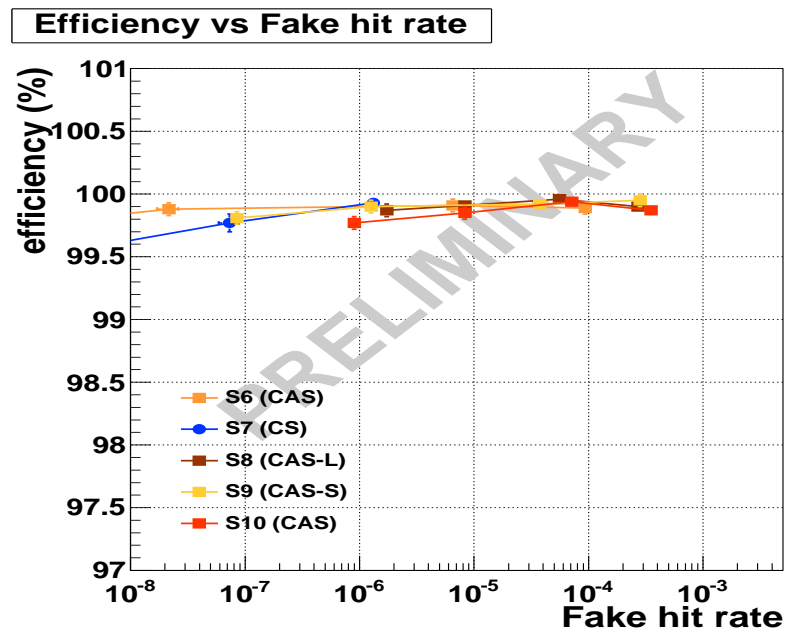
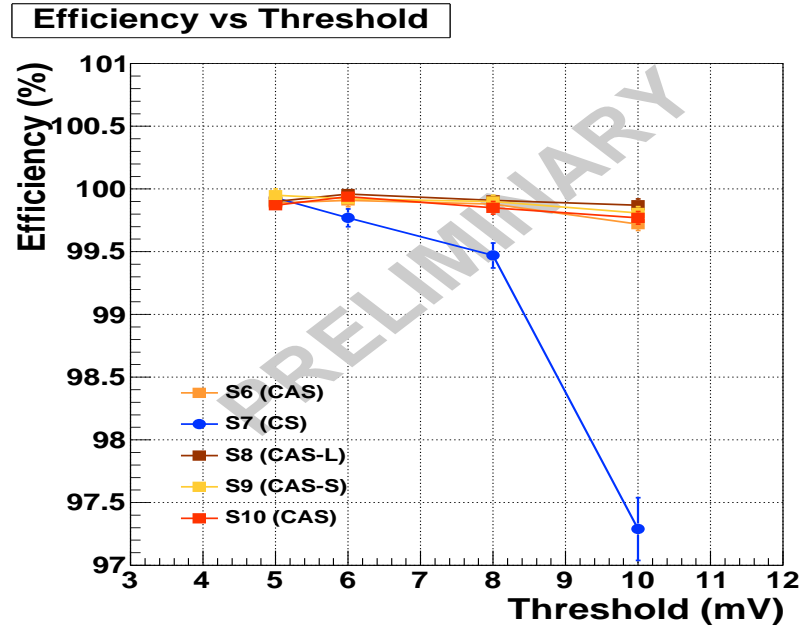


- Efficiency vs fake hit rate:

- ✧ define threshold values allowing high detection efficiency and low fake rate
- ⇒ keep fake rate $\lesssim 10^{-4}$

- Results for $20.7 \mu m$ pitch pixels ▷
mV-SNR equivalence at $30^\circ C$

Threshold ▷	6 mV	8 mV
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MIMOSA-22AHR: After 150 kRad

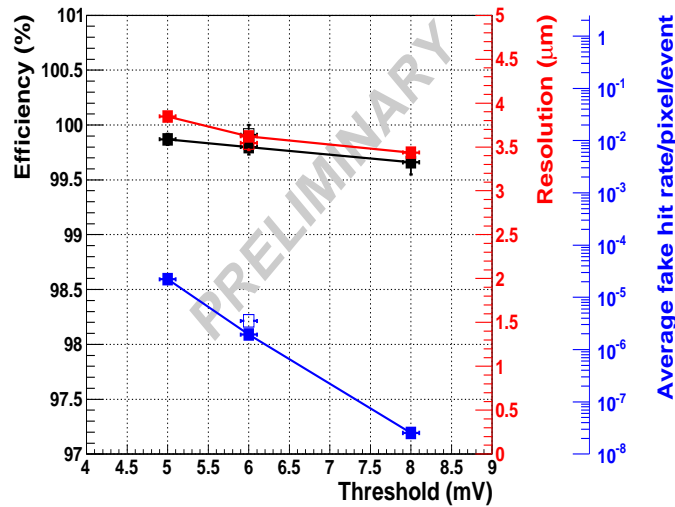
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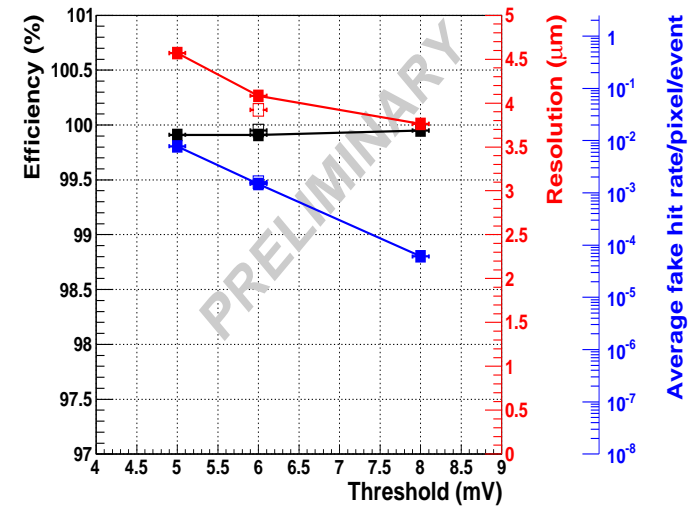
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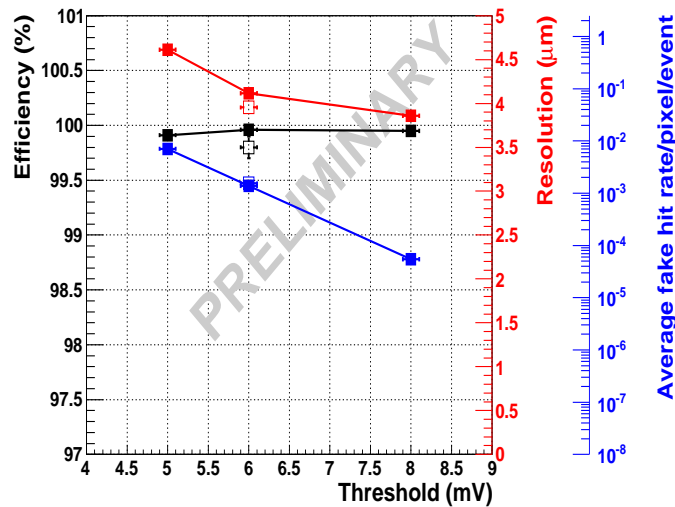
S7 (CS)



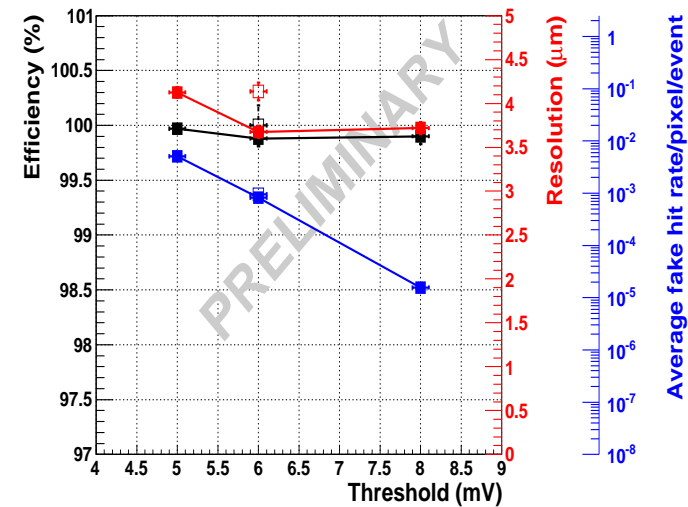
S10 (CAS)



S8 (CAS-L)



S6 (CAS)



MIMOSA-22AHR: After 150 kRad

- Efficiency vs fake hit rate:

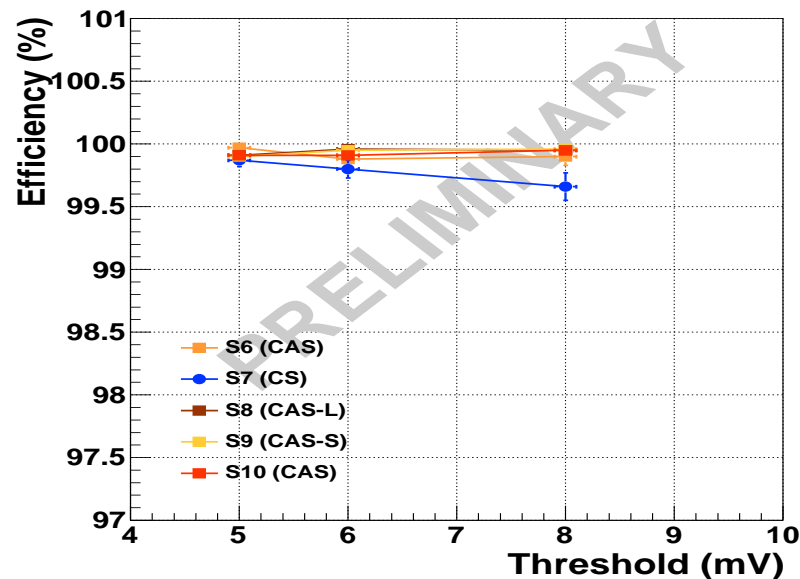
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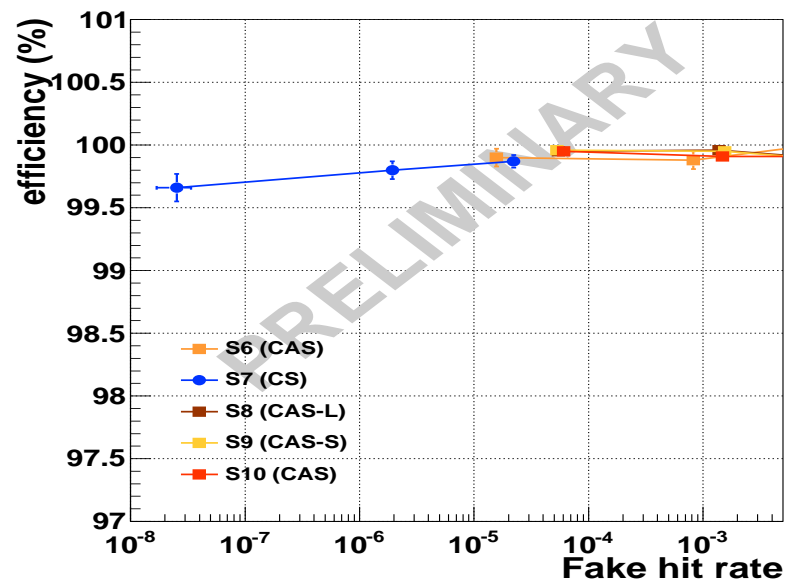
- Results for 20.7 μm pitch pixels \triangleright
mV-SNR equivalence at 30°C

Threshold \triangleright	5 mV	6 mV	8 mV
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S10	2.6	3.2	4.4
S6	2.7	3.4	4.6
S8	2.6	3.2	4.4

Efficiency vs Threshold at 30°C



Efficiency vs Fake hit rate at 30°C



MIMOSA-22AHR: After $3 \cdot 10^{12} n_{eq}/cm^2$ & 150 kRad at 75 MHz

Tests performed at CERN-SPS:

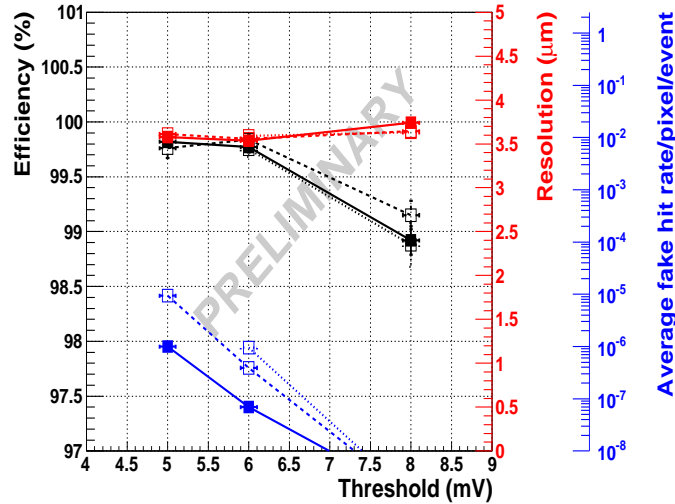
- * sensor mounted on beam telescope (4 pairs of Si-strip detectors)
- * vary discriminator threshold (JTAG), temperature = 20°C and 30°C, clock frequency = 75 MHz (instead of 100 MHz)
- * measure detection efficiency, fake hit rate, single point resolution

Results for 20.7 μm pitch pixels

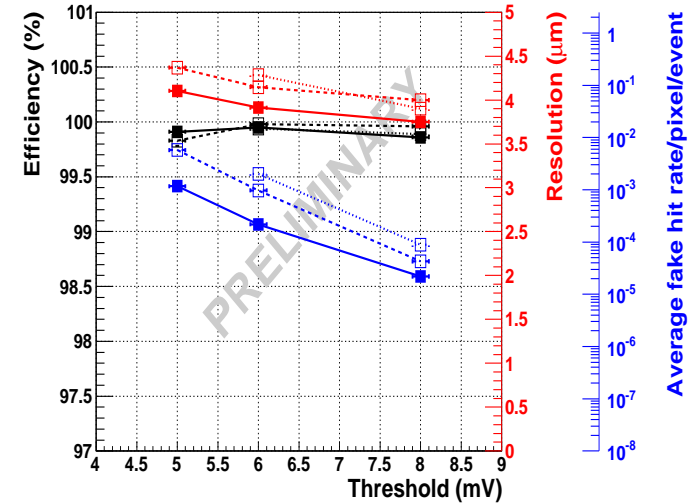
mV-SNR equivalence at 30°C

Threshold ▷	6 mV	8 mV
S7	5.2	6.9
S10	3.2	4.3
S9	3.2	4.3
S8	3.2	4.3

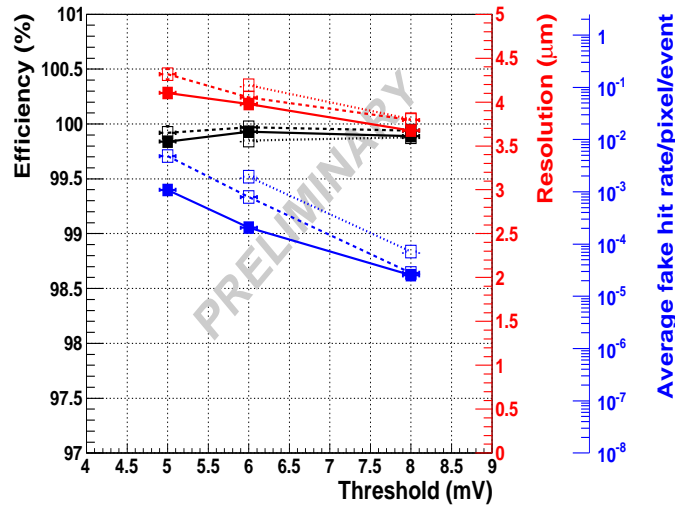
S7 (CS)



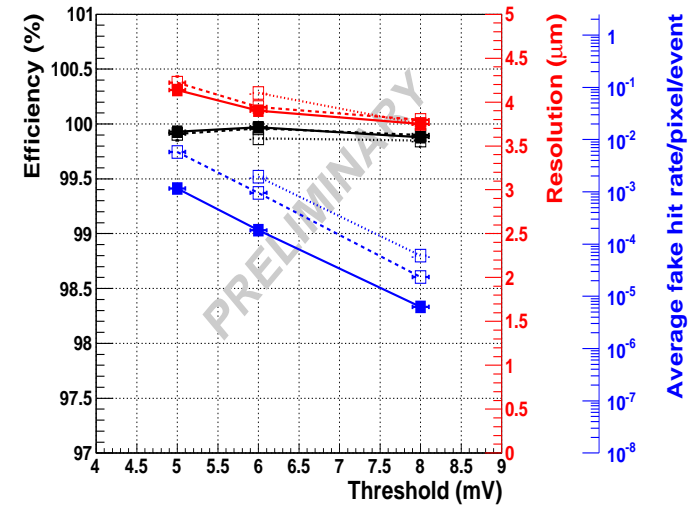
S10 (CAS)



S8 (CAS-L)



S9 (CAS-S)



MIMOSA-22AHR: After $3 \cdot 10^{12} n_{eq}/cm^2$ & 150 kRad at 75 MHz

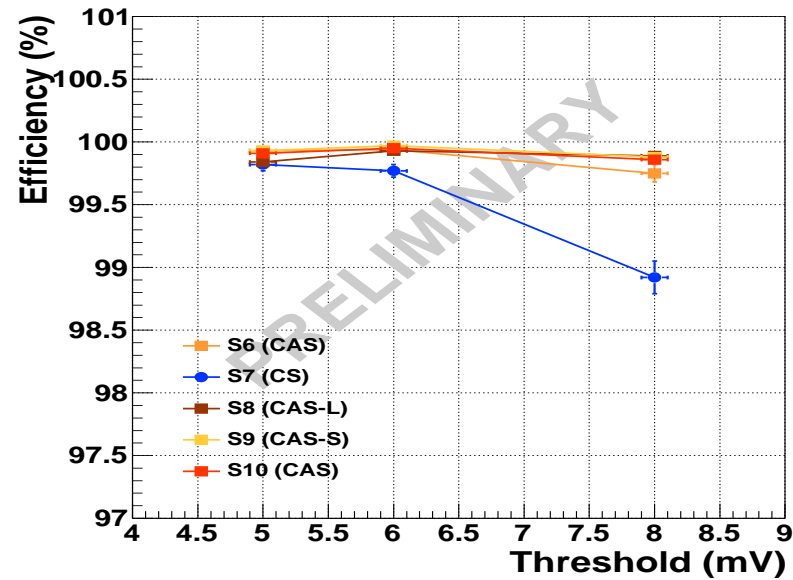
- Efficiency vs fake hit rate:

- ✧ define threshold values allowing high detection efficiency and low fake rate
- ⇒ keep fake rate $\lesssim 10^{-4}$

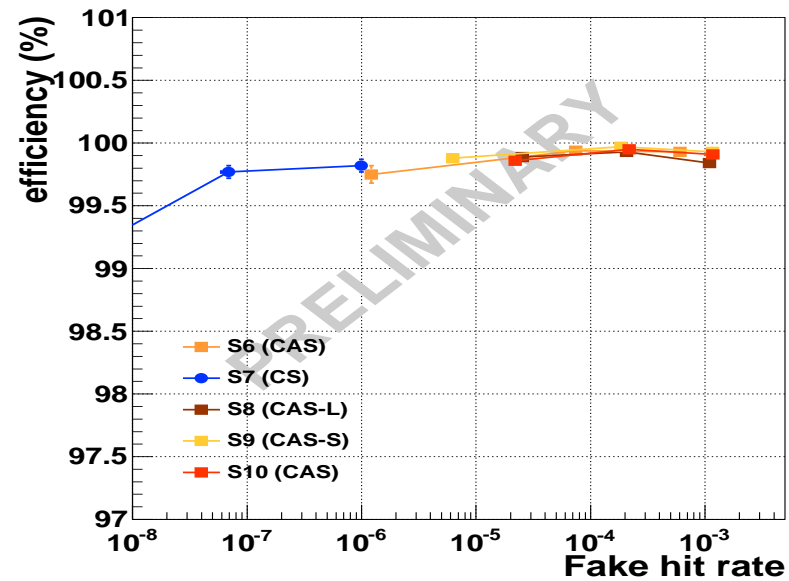
- Results for $20.7 \mu m$ pitch pixels \triangleright
mV-SNR equivalence at $30^\circ C$

Threshold \triangleright	6 mV	8 mV
S7	5.2	6.9
S10	3.2	4.3
S9	3.2	4.3
S8	3.2	4.3

Efficiency vs Threshold



Efficiency vs Fake hit rate



MIMOSA-22AHR S7 Pixel : Summary

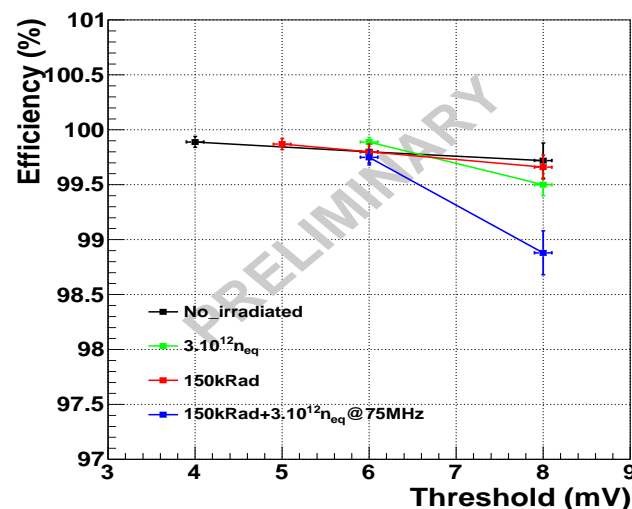
- Summary of results obtained with S7 (CS) :

- * evolution of detection efficiency
- * evolution of fake hit rate
- ↳ look for viable working point

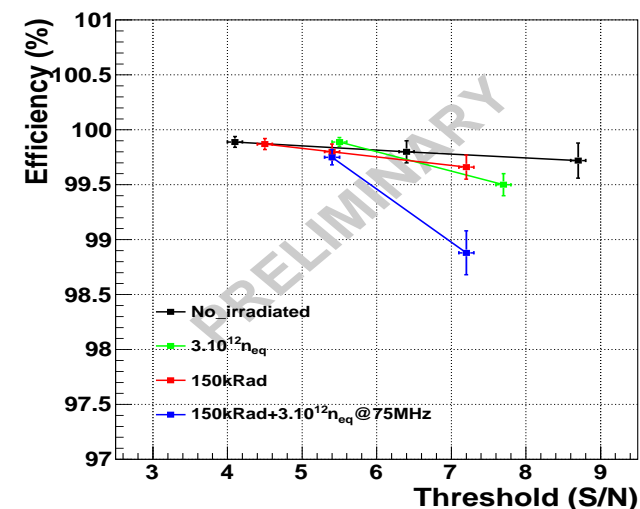
- Results for 20.7 μm pitch pixels ▷
mV-SNR equivalence at 30°C

Threshold (mV) ▷	4	5	6	8
before irradi.	4.1		6.4	8.7
$3 \cdot 10^{12} n_{eq}/cm^2$			5.5	7.7
150 kRad		4.5	5.4	7.2
combined (75 MHz)			5.2	6.9

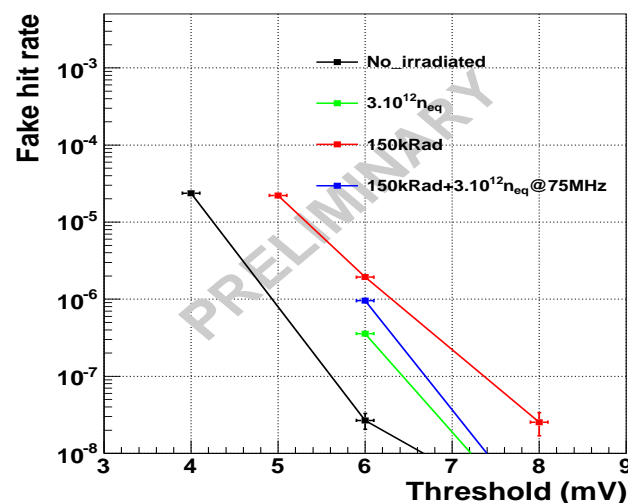
Efficiency vs Threshold



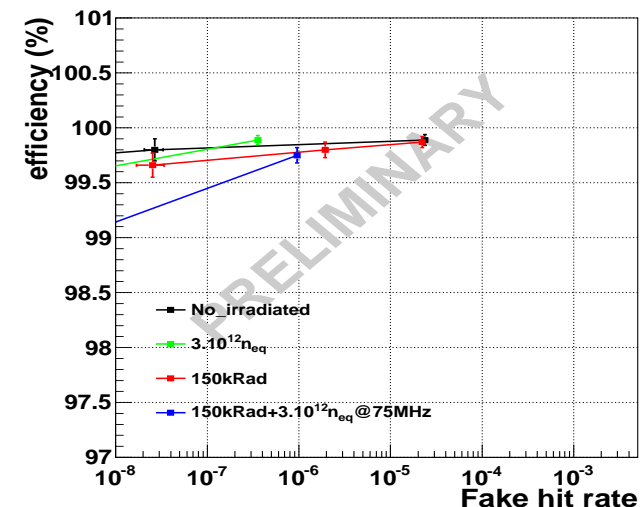
Efficiency vs Threshold



Fake hit rate (whole sensor) vs Threshold



Efficiency vs Fake hit rate



⇒ No problem to find a threshold where the detection efficiency is > 99.5 % while the fake hit rate remains negligible

MIMOSA-22AHR S10 Pixel : Summary

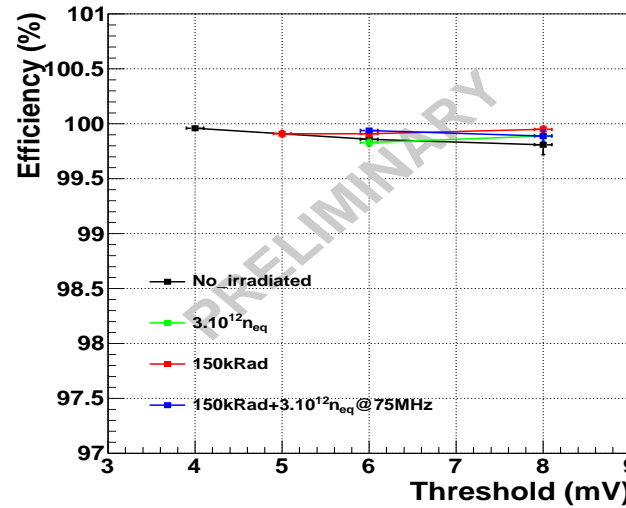
- Summary of results obtained with S10 (CS) :

- ✧ evolution of detection efficiency
- ✧ evolution of fake hit rate
- ↳ look for viable working point

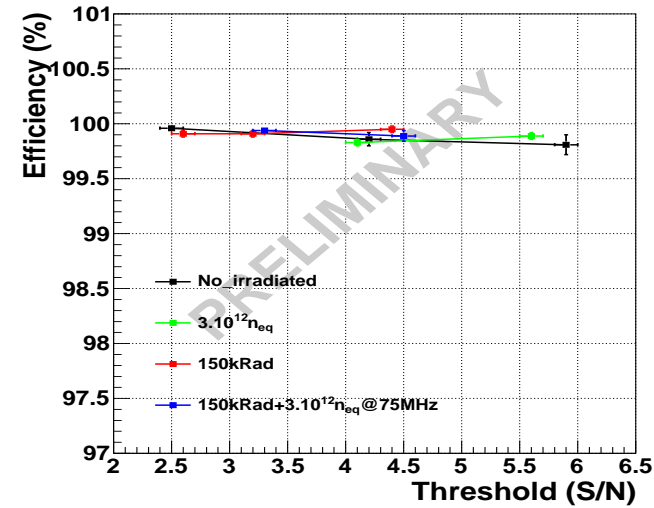
- Results for 20.7 μm pitch pixels ▷
mV-SNR equivalence at 30°C

Threshold (mV) ▷	4	5	6	8
before irradi.	2.5		4.2	5.9
$3 \cdot 10^{12} n_{eq}/cm^2$			4.1	5.6
150 kRad		2.6	3.2	4.4
combined (75 MHz)			3.2	4.3

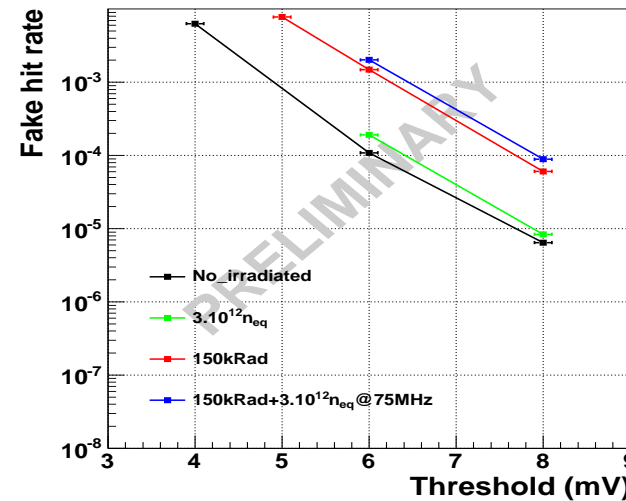
Efficiency vs Threshold



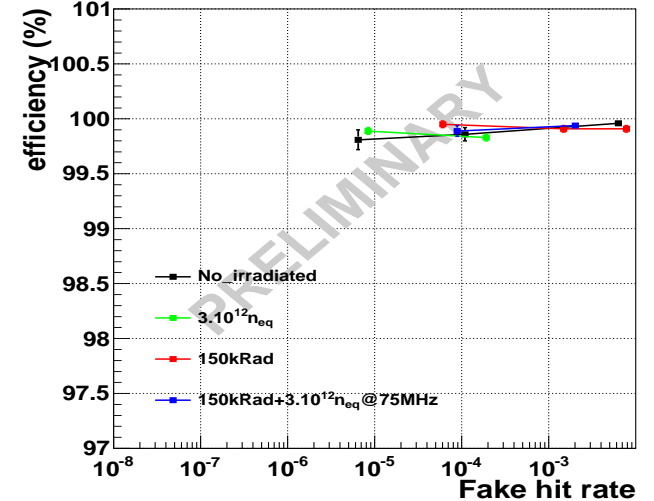
Efficiency vs Threshold



Fake hit rate (whole sensor) vs Threshold



Efficiency vs Fake hit rate



⇒ No problem to find a threshold where the detection efficiency is $> 99.5\%$ while the fake hit rate remains negligible

SUMMARY

- The design of ULTIMATE benefits from extensive experience and expertise gained with real scale sensors (PHASE-1, MIMOSA-26), many being thinned to $50 \mu m$, and widely used since ~ 2 years
- The use of a high-resistivity epitaxial layer was extensively studied
 - ⇒ it can reliably be used for ULTIMATE
- Various MIMOSA-26 pixels optimised for ULTIMATE were characterised on beam with MIMOSA-22AHR irradiated with $150 \text{ kRad} \oplus 3 \cdot 10^{12} n_{eq}/\text{cm}^2$ and operated at 30°C and with $\sim 125 \mu s$ integration time
 - ⇒ all pixel architectures (3.3 V) satisfy the specifications in terms of detection efficiency, fake hit rate, spatial resolution, radiation tolerance (no critical path identified)
 - ↪ operation at 3.0 V still to be fully validated (critical elements validated independently only)
- A slightly improved version of the MIMOSA-26 pixel (CS amplifier) was validated
 - ⇒ it offers the advantage of having been used on **numerous real scale** sensors (665,000 pixels)
- Details on ULTIMATE design and testing plans follow:
 - ✧ Overall design of upstream part (analogue and mixed circuitry) : Isabelle Valin
 - ✧ Design of zero-suppression and data transfer : Guy Dozière
 - ✧ Test & characterisation : Gilles Claus

BACK-UP SLIDES

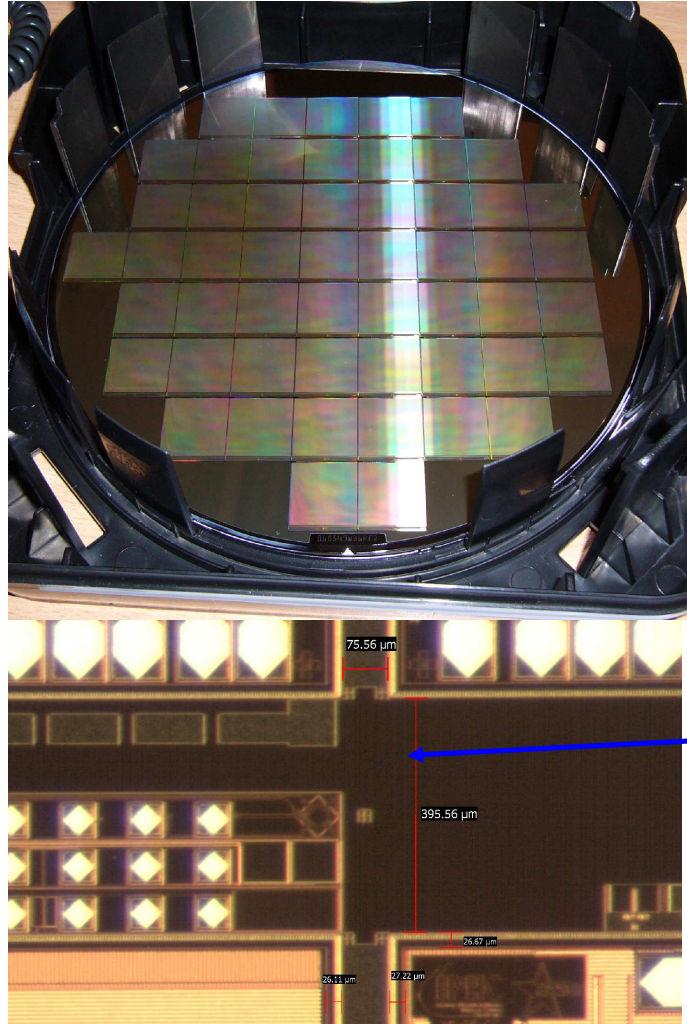
The Question of Butting

- **Motivations:**

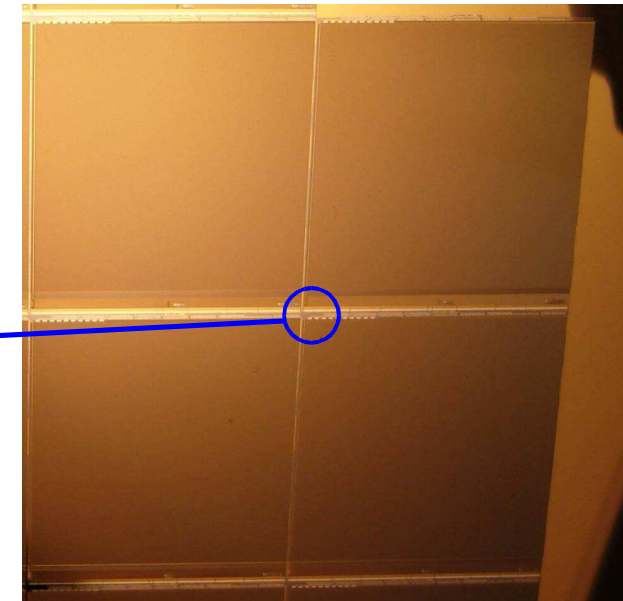
- ✧ simplified sensor assembly
- ✧ reduced insensitive area inbetween neighbouring sensors
- ✧ improved alignment

- **Plans with AMS-0.35 via CMP:**

- ✧ aim for $\lesssim 100 \mu m$ distance between sensitive arrays of neighbouring chips
- ✧ question of yield ?
- ✧ possibility of dicing ???

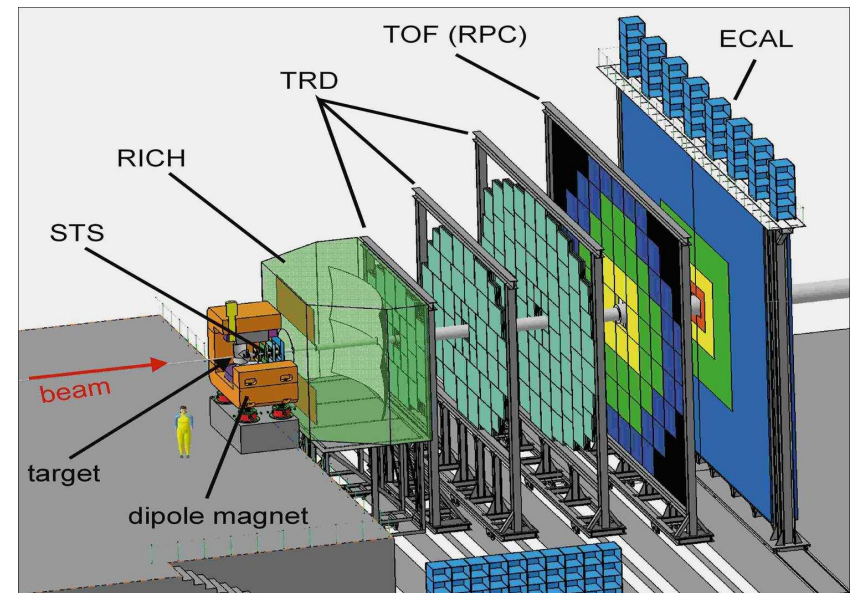


2009 wafer Mimosa23 (Phase1)
AMS 0.35



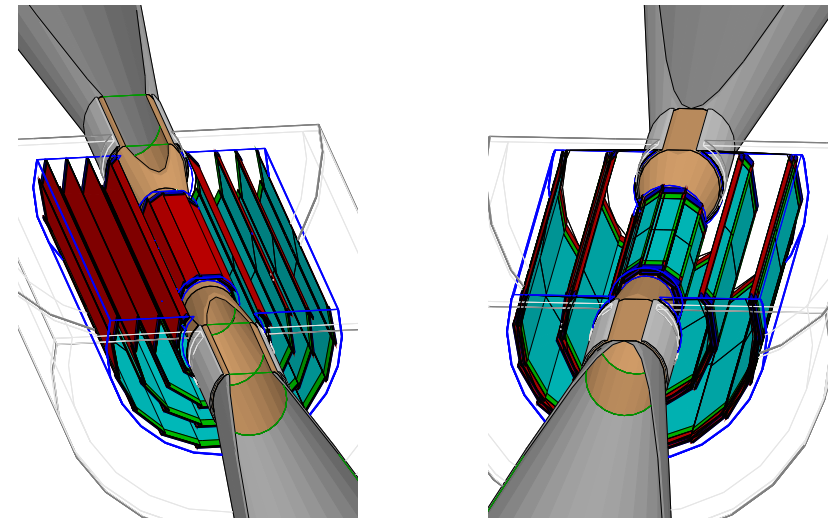
- **Vertex Detector of the CBM expt / FAIR**

- * 2 double-sided stations operated in vacuum
- * 0.3–0.5 % X_0 per station
- * $\lesssim 5 \mu m$ single pt resolution
- * $\lesssim 10 \mu s$ r.o. time
- * several MRad & $> 10^{13} n_{eq}/cm^2/s$
- * data taking $\gtrsim 2016$ (SIS-100) ... 2020 (SIS-300)



- **ILD Vertex Detector (option) :**

- * geometry : 3 double-sided or 5 single-sided layers
- * $\sim 0.2 \%$ X_0 total material budget per layer
- * $\sigma_{sp} \lesssim 3 \mu m$
- * r.o. time $\lesssim 25\text{--}100 \mu s$ (500 GeV)



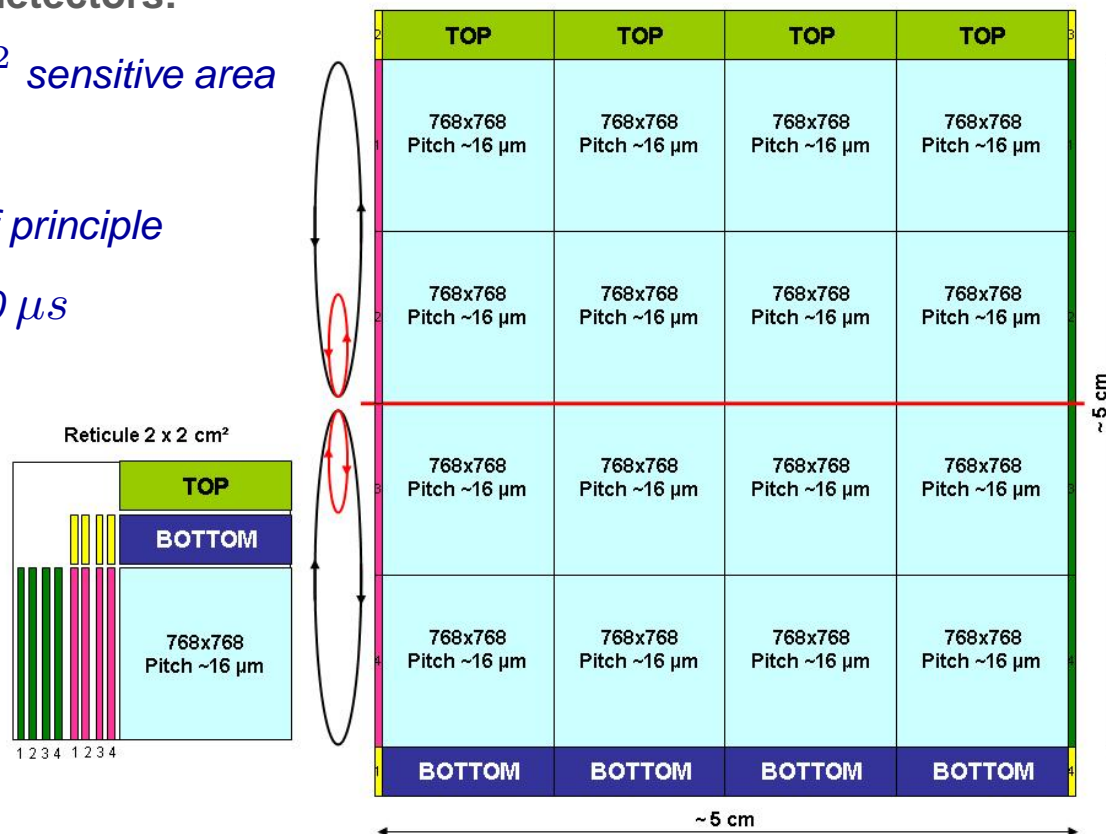
- **Other applications under consideration :**

VD/EIC, FOCAL/ALICE, VD/CLIC, (HL-)LHC upgrades, etc.

Investigating Large Area Sensors

- **Prototype multireticule sensor for "large" area detectors:**

- * 3072×3072 pixels ($16 \mu\text{m}$ pitch) $\Rightarrow 5 \times 5 \text{ cm}^2$ sensitive area
- * requires combining several reticules
 - \Rightarrow stitching process \Rightarrow establish proof of principle
- * double-sided read-out of 1536 rows in 250–300 μs
 - \Rightarrow Large Area Telescope for AIDA project
(EU-FP7 approved recently)
- * windowing of $\lesssim 1 \times 5 \text{ cm}^2$ (collim. beam)
 - $\Rightarrow \lesssim 50\text{--}60 \mu\text{s}$ r.o. time
- * 50-100 μm pitch variants under discussion
 - \Rightarrow suited to trackers & FW disks



- **Submission expected in 2012:**

- * bonus: avoid paving "large" areas with reticule size sensors \Rightarrow dead zones, material, connectics/complexity
- * synergy with tracker layers and forward disk projects on collider & fixed target experiments
- * 6 sensors will compose a beam telescope at CERN (AIDA project deliverable)
 - ▷ few ns time stamping resolution associated to each hit by TLU (scintillator)